

## 2:1 Mux/DeMux High Bandwidth HDMI<sup>™</sup> 2.1 Compliant Signal Switch

#### **Descriptions**

RLCS412Q series of switch circuits are targeted for high-resolution video network that are based on DVI/HDMI™ standard, and TMDS signal process. The RLCS412Q is an 8- to 4-Channel HMux/DeMux Switch. The device multiplexes differential signals to one of two corresponding outputs. The switch is bidirectional and offers little or no attenuation of the high-speed signals at the outputs. It is designed for low bit-to-bit skew and high channel-to-channel noise isolation.

The high bandwidth provides the resolution required by the next generation HDTV and PC graphics. Three differential channels are used for data (video signals for DVI or audio/video signals for HDMI), and one differential channel is used for Clock for decoding the TMDS signals at the outputs.

Because of its passive bidirectional feature, this switch can be used either at the video driver side or at the receiver side. For PC graphics applications, the device sits at the driver side to switch between multiple display units such as LCD monitor, projector, TV, etc. For consumer video applications, the device sits at the receiver GELECTRONIC TERMINE end to switch between the source components such as DVD, D-VHS, STB, etc.

#### **Features**

- 4-Differential Channel 2:1 Mux/DeMux
- HDMI 2.1 compatible
- High Bandwidth: 5.7GHz @-3dB BW
- Supports both AC coupled and DC coupled signals
- $\triangleright$ Isolation: -40dB @ 2.0 Gbps
- Crosstalk: -31dB @ 2.0 Gbps
- ESD Tolerance: 2kV HBM  $\triangleright$
- Low bit-to-bit skew, Bidirectional

### **Applications**

- Routing of HDMI 2.1 video signals with low signal attenuation between source and sink for 4K2K ultra high definition video display and broadcast video equipment.
- Routing of DisplayPort video signals with low signal attenuation between source and sink for PC and monitor.

#### Order information

Package		Part Number	Quantity per Reel		
QFN 9×3.5-42L	Tape and Reel	RLCS412QN42/R6	3000PCS		



### **Block Diagram and Pin Configuration**

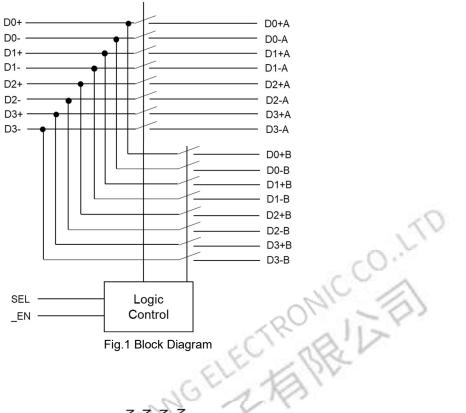


Fig.1 Block Diagram

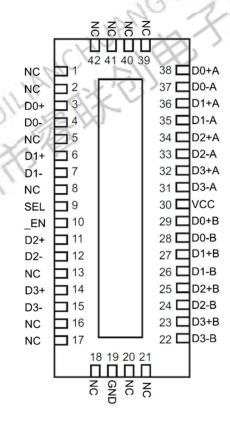


Fig.2 Top-Through View



# **Pin Description**

Pin#	Pin Name	Signal Type	Description		
3	D0+	I/O	Positive differential signal 0 for COM port		
4	D0-	I/O	Negative differential signal 0 for COM por		
6	D1+	I/O	Positive differential signal 1 for COM port		
7	D1-	I/O	Negative differential signal 1 for COM port		
9	SEL	I	Select Pin, See Truth Table		
10	_EN	I	Enable Pin, Active Low		
11	D2+	I/O	Positive differential signal 2 for COM port		
12	D2-	I/O	Negative differential signal 2 for COM port		
14	D3+	I/O	Positive differential signal 3 for COM port		
15	D3-	I/O	Negative differential signal 3 for COM port		
19	GND	Ground	Power Ground		
22	D3-B	I/O	Negative differential signal 3 for port B		
23	D3+B	I/O	Positive differential signal 3 for port B		
24	D2-B	I/O	Negative differential signal 2 for port B		
25	D2+B	I/O	Positive differential signal 2 for port B		
26	D1-B	I/O	Negative differential signal 1 for port B		
27	D1+B	I/O	Positive differential signal 1 for port B		
28	D0-B	I/O	Negative differential signal 0 for port B		
29	D0+B	I/O	Positive differential signal 0 for port B		
30	VCC	Power	Positive Supply Voltage		
31	D3-A	1/0	Negative differential signal 3 for port A		
32	D3+A	I/O	Positive differential signal 3 for port A		
33	D2-A	I/O	Negative differential signal 2 for port A		
34	D2+A	1/0	Positive differential signal 2 for port A		
35	D1-A	I/O	Negative differential signal 1 for port A		
36	D1+A	I/O	Positive differential signal 1 for port A		
37	D0-A	I/O	Negative differential signal 0 for port A		
38	D0+A	I/O	Positive differential signal 0 for port A		
Others	NC	/	Not Connected		
	i l		I .		

# **Truth Table**

_EN	SEL	Dx+/-						
High	Х	Hi-Z						
Low	Low	Dx+/-A						
Low	High	Dx+/-B						

### Note:

1. x=0,1,2,3



### **Maximum Ratings**

(Above which useful life may be impaired. For user guidelines, not tested.)

Storage Temperature	-65℃ to +150℃
Junction Temperature	125°C
Supply Voltage to Ground Potential	-0.5V to +5.5V
High Speed Data Channel D0~D3	-0.5V to 3.8V
CEC, SCL, SDA, HPD	-0.5V to 5.5V
DC Input Voltage	-0.5V to VCC
DC Output Current	120mA
Power Dissipation	0.5W

#### Notes:

Stresses greater than those listed under MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.



### **Electrical Characteristics**

	Parameter		Test conditions <sup>(1)</sup>	Min	Typ. <sup>(2)</sup>	Max	Unit
PORT A							
		D0 to D3	V <sub>CC</sub> =3V,		6.5	9.5	Ω
R <sub>on</sub>	ON-state resistance	SCL,SDA,	1.5V≤V <sub>I/O</sub> ≤V <sub>CC</sub> ,			0.5	
		HPD,CEC	I <sub>I/O</sub> =-40mA		6	9.5	Ω
В	ON-state resistance	All I/O	V <sub>CC</sub> =3V, V <sub>I/O</sub> =1.5V		1.5		0
$R_{ON(flat)}$	flatness	All I/O	and V <sub>CC</sub> ,I <sub>I/O</sub> =-40mA		1.5		Ω
	On-state resistance		V <sub>cc</sub> =3V,1.5V≤V <sub>I/O</sub> ≤V <sub>cc</sub> ,				
$\Delta R_{\text{ON}}$	match between high-	D0 to D3	I <sub>VO</sub> =-40mA		0.4	1	Ω
	speed channels		1//04011/4				
I <sub>OFF</sub>	Leakage under power	All outputs	$V_{CC}$ =0V, $V_{I/O}$ =0V to		±10		uA
IOFF	off	All outputs	3.6V , V <sub>IN</sub> =V to 5.5V		±10		uA
PORTB							6
		D0 to D3	V <sub>CC</sub> =3V,		8.2	10.5	Ω
R <sub>ON</sub>	ON-state resistance	SCL,SDA,	1.5V≤V <sub>I/O</sub> ≤V <sub>CC</sub> ,		6.0	9.5	Ω
		HPD,CEC	I <sub>I/O</sub> =-40mA		6	9.5	115
	ON-state resistance	AULIO	V <sub>CC</sub> =3V, V <sub>I/O</sub> =1.5V	. 6	1.5	S	Ω
$R_{ON(flat)}$	flatness	All I/O	and V <sub>CC</sub> ,I <sub>I/O</sub> =-40mA	1	1.5	151	12
	On-state resistance		V <sub>cc</sub> =3V,1.5V≤V <sub>I/O</sub> ≤V <sub>cc</sub> ,	1	N		l
$\Delta R_{ON}$	match between high-	D0 to D3	$I_{VO} = -40 \text{mA}$	1	0.4	1	Ω
	speed channels		1 <sub>1/0</sub> 40111A	2			
	Lookaga undar nawar off	A11	V <sub>CC</sub> =0V, V <sub>I/O</sub> =0V to			±10	uA
l <sub>OFF</sub>	Leakage under power off	All outputs	3.6V , V <sub>IN</sub> =V to 5.5V			±10	uA
DIGITAL II	NPUTS(SEL1,SEL2,EN1,EN	l2)	THE STATE OF THE S				
VIH	High-level control input	19	7	1.4			V
VIII	voltage	70		1.4			v
VIL	LOW-level control input	SEL1,				0.5	V
VIL	voltage	SEL2,				0.5	v
VIH	Digital input high	EN1, EN2	V <sub>CC</sub> =3.6V, V <sub>IN</sub> =VCC			±10	uA
VIII	leakage current	LINI, LINZ	V <sub>CC</sub> -3.0V, V <sub>IN</sub> -VCC			110	uA
VIL	Digital input low leakage		V <sub>CC</sub> =3.6V, V <sub>IN</sub> =GND			±10	uA
VIL	current		VCC-3.0V, VIN-GIND			110	uA
SUPPLY							
			V <sub>CC</sub> =3.6V, I <sub>I/O</sub>				
I <sub>CC</sub>	VCC supply current		=0,Normal operation		100		uA
			mode, _ENx=L				
I <sub>CC</sub> , PD	VCC supply current in pow	ver-down	V <sub>CC</sub> =3.6V, I <sub>I/O</sub> =0,		2		uA
ICC, FU	mode		_ENx=H				uA

#### Notes:

- 1.  $V_I$ , Vo.  $I_I$ , and  $I_O$  refer to I/O pins,  $V_{IN}$  refers to the control inputs.
- 2. All typical values are at Vcc = 3.3 V (unless otherwise noted), TA = 25°C.
- 3. R<sub>(ON/FLAT)</sub> is the difference of R<sub>ON</sub> in a given channel at specified voltages.
- 4.  $\Delta R_{ON}$  is the difference of  $R_{ON}$  from center port to any other ports.



Switching Characteristics (TA= -40 °C to +105 °C, VCC=3.3V±10%)

$T_{pd}$	Description	Min.	Тур.	Max	Unit
ı pa	Propagation delay (input pin to output pin) on all channels		80		ps
t <sub>b-b</sub>	Bit-to-bit skew within the same differential pair of Dx± channels		5	7	ps
t <sub>ch-ch</sub>	Channel-to-channel skew of Dx+ channels			35	ps
Tsw a-b	Time it takes to switch from port A to port B			0.1	us
Tsw b-a	Time it takes to switch from port B to port A			0.1	us
Tstartup	VCC valid to channel enable			10	us
Twakeup	Enabling output by changing OE from low to High		0	10	us
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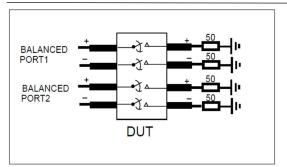
**Dynamic Electrical Characteristics Over Operating Range (TA=**  $-40^{\circ}$  to  $+105^{\circ}$ C, VCC=3.3V±10%)

Parameter	Description	Test con	ditions	Min.	Тур.	Max	Unit	
Crosstalk on High		f = 3.0GHz		-25	-22			
	Crosstalk on High	See Fig.3 for Measurement setup	f = 2.7GHz		-28	-25	_	
XTALK	Speed Channels		f = 1.7GHz		-31	-28		
			f = 1.35GHz		-32	-28	40	
			f = 3.0GHz		-22	-20	dB	1
Oues	OFF Isolation on OIRR High Speed Channels	See Fig.4 for Measurement setup	f = 2.7GHz		-22	-20	21,77	
OIRR			f = 1.7GHz	_	-29	-26		0
			f = 1.35GHz	CEC	-30	-27		
ı	Different Insertion	@3.0GHz(	see Fig.5)	-2.0	-1.7		-ID	
ILOSS	Loss on High Speed Channels	@5.4GHz(see Fig.5)		-2.0	-1.7		dB	
Different Return Loss	@3.0GHz(6.0Gbps)			- 16.0	-14	4D		
<b>N</b> LUSS	R <sub>LOSS</sub> on High Speed Channels	@2.7GHz(5.4Gbps)			- 14.0	- 12.5	dB	
BW	Bandwidth -3dB	see Fig.5			5.7		GHz	

#### Note:

- 1. For Max. or Min. conditions, use appropriate value specified under Electrical Characteris-tics for the applicable device type.
- 2. Typical values are at VCC=3.3V,TA=25°C ambient and maximum loading.





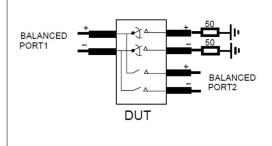
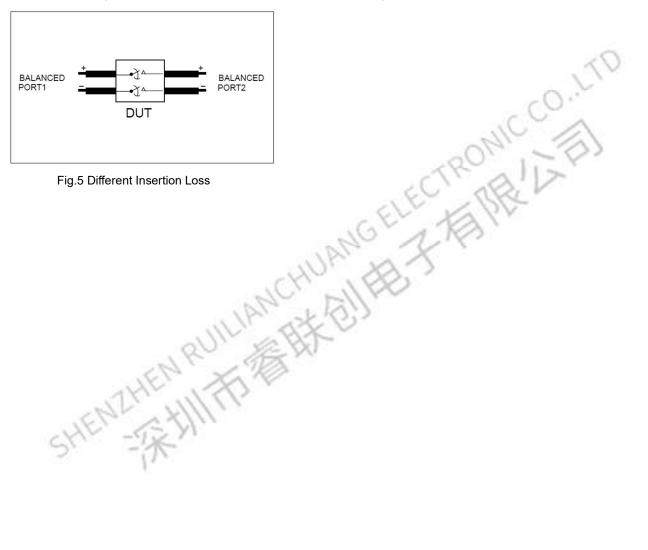


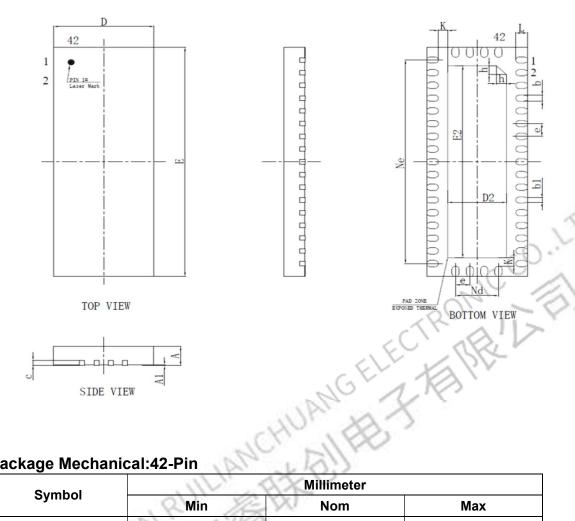
Fig.3 Crosstalk Setup

Fig.4 OFF-isolation





## **Package Outline Dimensions**



Package Mechanical:42-Pin

Cymah al	Millimeter					
Symbol	Min	Nom	Max			
Α	0.70	0.75	0.80			
A1	0	0.02	0.05			
b	0.20	0.25	0.30			
b1 -	X YI	0.18REF				
С	1	0.203REF				
D	3.40	3.50 3.60				
D2	1.95 2.05 2.15					
е	0.50BSC					
Nd		1.50BSC				
E	8.90	8.90 9.00 9.10				
E2	7.45 7.55 7.65					
Ne	8.00BSC					
L	0.35	0.35 0.40 0.45				
h	0.30 0.35 0.40					
K	0.325REF					





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